# A Novel Semi-Supervised Classification Method Based on Class Certainty of Samples

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**Abstract.**—The traditional classification method based on supervised learning classifies remote sensing (RS) images by using sufficient labeled samples. However, the number of labeled samples is limited due to the expensive and time-consuming collection. To effectively utilize the information of unlabeled samples in the learning process, this paper proposes a novel semi-supervised classification method based on class certainty of samples (CCS). First, the class certainty of unlabeled samples obtained based on multi-class SVM is smoothed for robustness. Then, a new semi-supervised linear discriminant analysis (LDA) is presented based on class certainty, which improves the separability of samples in the projection subspace. Ultimately, we extend the semi-supervised LDA to nonlinear dimensional reduction by combining class certainty and kernel methods. Furthermore, to assess the effectiveness of proposed method, the nearest neighbor classifier is adopted to classify actual SAR images. The results demonstrate that the proposed method can effectively exploit the information of unlabeled samples and greatly improve the classification effect compared with other state-of-the-art approaches.

**Keywords:** remote sensing images; semi-supervised classification; class certainty; semi-supervised LDA; kernel method

# 1 Introduction

With the rapid development of the remote sensing (RS) technology, the higher-resolution and more informative RS images are acquired. Due to the classification ability under certain conditions, RS images has been widely applied to areas such as target surveillance, disaster relief, environmental protection and *etc*[1,2]. However, it's difficult to achieve accurate classification of RS images, which has become one of research hotspots[3].

The traditional RS images classification technologies are mainly based on unsupervised learning [4]and supervised learning [5]. Unsupervised methods cluster the similar samples together by exploiting the characteristic distribution of samples. Since prior knowledge is not required, unsupervised learning methods are easy to implement. However, since such methods only consider the characteristic difference among samples and lack the effective guidance of label information, the classification performance is not idea normally. To overcome the aforementioned disadvantage, the supervised methods are adopted to quickly capture the label information by learning the mapping function between the features and labels of training data[6]. The classification performance of supervised methods are significantly improved with sufficient labeled samples. Nevertheless, the sample labeling for RS images is time-consuming, and the robustness of the classifier is worse when the labelled samples are insufficient [7]. But unlabeled samples can be generated in a relatively easier way and their rich characteristic information is helpful for improving the classification performance[8]. Semi-supervised learning can automatically exploits unlabeled samples to improve the learning performance based on labeled samples.

Generally, it's believed that the first semi-supervised method is proposed by Shahshahani and Landgrebe in 1994 [9]. Ever since, many semi-supervised learning methods has been presented, such as

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generative mode, semi-supervised SVM [10], graph-based model [11], self-training model and colearning model [12]. For the semi-supervised algorithms, unlabeled samples are used to enlarge initial labeled samples set and make the classification surface pass through the space with sparse samples. In [13], the transductive support vector machine(TSVM) is developed to search the optimal classification surface based on margin maximization by iteratively assigning the sample positive label or negative one. Persello and Bruzzone present a progressive semi-supervised SVM with diversity (PS3VM-D) to make candidate samples within and closer to the margin band [14]. Then, samples are incrementally selected among the candidates considering the kernel cosine-angular similarity. Based on co-training model, Zhou designed a tri-training algorithm by training three classifiers. Then, reliable unlabeled samples are selected by one classifier and added to the labeled samples set of the other two classifiers in an iterative way [15]. Although the aforementioned algorithms are proved to be effective experimentally, semisupervised learning methods are not always helpful because of the strict requirements of data distribution, selection method and labeling method for unlabeled samples.

To effectively improve RS images classification performance, this paper proposes a novel semisupervised classification method by utilizing unlabeled samples based on class certainty of samples (CCS). Different from other semi-supervised algorithms, CCS initially assigns the class certainty to unlabeled samples and integrates it to the scatter matrixes of linear discriminant analysis (LDA). The new scatter matrixes can effectively describe the true characteristic distribution, which makes samples more separable in the projection subspace. Since the class certainty is used to measure the class reliability of samples, the unlabeled samples with high reliability play a more important role than those with low reliability in CCS. To ensure the sufficient class reliability of unlabeled samples in the subsequent semisupervised process, the class certainty is smoothed through normalization and threshold considering the complicated distribution of samples. As a result, the performance of CCS is greatly improved.

The rest of this paper is organized as follows. Section 2 describes the proposed method in detail. The experiments for the SAR targets classification are provided in Section 3 and the conclusions are drawn in Section 4.

# 2 Proposed Method

In this part, we first present the related definition. The training samples  $X = [L, U] \in \mathbb{R}^{d \times N}$  are divided into two parts according to the label of samples. Let  $L = [x_1, x_2, \dots, x_l] \in \mathbb{R}^{d \times l}$  be the feature matrix of labeled samples with label vector  $[y_1, y_2, \dots, y_l]$ ,  $y_i \in \{1, 2 \dots, k\}$  and  $U = [x_{l+1}, x_{l+2}, \dots, x_{l+u}] \in \mathbb{R}^{d \times u}$  be the feature matrix of unlabeled samples. N = l + u denotes the number of training samples and the test set is T. Then, as shown in Fig 1, the proposed novel semisupervised method (CCS) consists of four main ingredients.



Fig 1. Flowchart of the proposed method CCS.

# 2.1 Getting the class certainty of unlabeled samples

## **Dimension reduction of Training data**

In Fig 1, the inputs of CCS are the original RS training data L and U in high-dimension. To get the class certainty information quickly, the computational complexity and the dimension of training data should be reduced. Thus, based on KLDA algorithm, the projection characteristics  $L_1$  and  $U_1$  are obtained.

#### Computing the class certainty based on multi-class SVM

The output of SVM can effectively measure the class certainty of samples. After the dimension reduction, SVM can be trained based on the labeled samples  $L_I$ . Because the samples are generally multiclass, we construct multi-class SVM based on the "one-against-one" approach. To express more clearly, an example of constructing multi-class SVM and getting the class *m* certainty of unlabeled samples is shown in Fig 2.



Fig 2. Constructing the multi-class SVM and getting the class *m* certainty of unlabeled samples.  $L_1^m$  denotes labeled samples of class *m* with reduced dimension.

Let  $L_1^m$  and samples of the other classes be positive labels and negative labels, respectively. Then, after training k-1 binary SVM between  $L_1^m$  and other classes of samples, the corresponding output vector is derived by passing  $U_1$  to every binary SVM. For example:  $f^{m,m-1} = (w^T \phi(U_1) + b)^T$  denotes the output vector of the SVM trained by  $L_1^m$  and  $L_1^{m-1}$ . Obviously, different output vectors can be obtained in this way. To get the class *m* certainty  $f_U^m$ , the output vectors are added based on the idea of voting method. Similarly, other class certainty  $f^i, i = 1, 2 \cdots, k, i \neq m$  can be obtained according to the corresponding implementation.

#### 2.2 Smooth processing of the class certainty

#### Normalization and threshold processing

Since the class *i* certainty  $f_U^i$  ( $i \in \{1, 2\dots, k\}$ ) contains elements ranged from less than 0 to larger than 1, they should be normalized and threshold processed before utilizing. Accordingly, min-max standard method is applied for analysis, which can be written as

$$\boldsymbol{p}_{U}^{i} = \frac{\boldsymbol{f}_{U}^{i} - \min}{\max - \min} , \quad i \in \{1, 2 \cdots, k\}$$

$$\tag{1}$$

where  $p_U^i$  represents the class *i* certainty of U after normalization processing. Then, we choose threshold  $t \in [0,1]$ . If the element of  $p_U^i$  is less than *t*, we set it to 0.

$$\boldsymbol{p}_{U,j}^{i} = \begin{cases} 0, \, \boldsymbol{p}_{U,j}^{i} < t \\ \boldsymbol{p}_{U,j}^{i}, \, \text{others} \end{cases}, i \in \{1, 2 \cdots, k\}, \, j \in \{1, 2 \cdots u\}$$
(2)

where  $p_{U,j}^{i}$  denotes the j-th element of vector  $p_{U}^{i}$ . The greater threshold *t* means higher reliability requirement for the utilized unlabeled samples.

## Merge the class certainty of labeled samples

Assuming that  $L^i, i \in \{1, 2..., k\}$  is the original labeled sample set of class *i*. It's obvious that the corresponding class *i* certainty is 1 and the other class certainty is 0. Thus, the class *i* certainty vector  $p_L^i$  of L can be derived as

$$\boldsymbol{p}_{L,j}^{i} = \begin{cases} 1, y_{j} = i \\ 0, y_{j} \neq i \end{cases}, i \in \{1, 2\cdots, k\}, j \in \{1, 2\cdots l\} \end{cases}$$
(3)

where  $p_{L,j}^{i}$  and  $y_{j}$  denote the j-th element of vector  $p_{L}^{i}$  and the label of sample  $x_{j}$ , respectively. By combining  $p_{L}^{i}$  and  $p_{U}^{i}$ , the class *i* certainty vector of training data X = [L, U] is obtained:

$$\boldsymbol{p}^{\prime} = [\boldsymbol{p}_{L}^{\prime}, \boldsymbol{p}_{U}^{\prime}], i \in \{1, 2\cdots, k\}$$

$$\tag{4}$$

## 2.3 New semi-supervised LDA

## Semi-supervised LDA

In this section, we propose a novel semi-supervised LDA method by integrating class certainty into the scatter matrixes so that the samples are more separable in the projection subspace. To derive the new scatter matrixes, the within-class mean vector  $u_i$  and the total mean vector u are defined as:

$$\boldsymbol{u}_{i} = \frac{\sum_{j=1}^{N} \boldsymbol{p}_{j}^{i} \boldsymbol{x}_{j}}{\sum_{j=1}^{N} \boldsymbol{p}_{j}^{i}} = \boldsymbol{X} \left( \boldsymbol{p}_{j}^{i} / \sum_{j=1}^{N} \boldsymbol{p}_{j}^{i} \right) = \boldsymbol{X} \boldsymbol{\widehat{p}}^{i}$$

$$\boldsymbol{u} = \frac{\sum_{i=1}^{k} \sum_{j=1}^{N} \boldsymbol{p}_{j}^{i} \boldsymbol{x}_{j}}{\sum_{i=1}^{k} \sum_{j=1}^{N} \boldsymbol{p}_{j}^{i}} = \boldsymbol{X} \left( \sum_{i=1}^{k} \boldsymbol{p}^{i} / \sum_{i=1}^{k} \sum_{j=1}^{N} \boldsymbol{p}_{j}^{i} \right) = \boldsymbol{X} \boldsymbol{\widehat{p}}$$
(5)

Where  $\boldsymbol{p}_{i}^{i}$  is the element of vector  $\boldsymbol{p}^{i}$ .

Next, to obtain the "generalized Rayleigh quotient" of semi-supervised LDA, the new betweenclass scatter matrix  $S_b$ , within-class scatter matrix  $S_w$  and total-class scatter matrix matrixes  $S_t$  are defined as

$$S_{b} = \sum_{i=1}^{k} n_{i} (\boldsymbol{u}_{i} - \boldsymbol{u}) (\boldsymbol{u}_{i} - \boldsymbol{u})^{T}$$
$$= \boldsymbol{X} [\sum_{i=1}^{k} n_{i} (\widehat{\boldsymbol{p}}^{i} - \widehat{\boldsymbol{p}}) (\widehat{\boldsymbol{p}}^{i} - \widehat{\boldsymbol{p}})^{T}] \boldsymbol{X}^{T}$$
$$= \boldsymbol{X} \widehat{\boldsymbol{S}}_{b} \boldsymbol{X}^{T}$$
(6)

where  $n_i = \sum_{j=1}^{N} p_j^i$ .  $S_w = \sum_{i=1}^{k} \sum_{j=1}^{N} p_j^i (\boldsymbol{x}_j - \boldsymbol{u}_1) (\boldsymbol{x}_j - \boldsymbol{u}_1)^T$   $= X [\sum_{i=1}^{k} \sum_{j=1}^{N} p_j^i (\boldsymbol{h}_j - \hat{\boldsymbol{p}}^i) (\boldsymbol{h}_j - \hat{\boldsymbol{p}}^i)^T] X^T$   $= X \widehat{S}_w X^T$   $S_t = \sum_{i=1}^{k} \sum_{j=1}^{N} p_j^i (\boldsymbol{x}_j - \boldsymbol{u}) (\boldsymbol{x}_j - \boldsymbol{u})^T$   $= X [\sum_{i=1}^{k} \sum_{j=1}^{N} P_j^i (\boldsymbol{h}_j - \hat{\boldsymbol{p}}) (\boldsymbol{h}_j - \hat{\boldsymbol{p}})^T] X^T$   $= X \widehat{S}_t X^T$ (8)  $= X \widehat{S}_t X^T$ 

where  $\boldsymbol{h}_i \in \boldsymbol{R}^{N \times 1}$  is expressed as:

$$\boldsymbol{h}_{j,i} = \begin{cases} 1, i = j \\ 0, else \end{cases} \tag{9}$$

where *i* denotes the element subscript of vector  $\boldsymbol{h}_i$ .

According to Eq.(6),(7) and (8), the main difference between our method and supervised LDA is that the definition of  $n_i$  for  $S_b$  is changed and the weight  $p_j^i$  is added to  $S_w$  and  $S_t$ . The higher class i certainty of sample  $x_j$  means larger  $p_j^i$  and greater impact on the scatter matrixes. On the contrary, a smaller  $p_j^i$  means less impact on the scatter matrixes. This method effectively exploits the characteristic information of unlabeled samples and significantly reduces the impact of wrong classified samples. Thus, the scatter matrixes shows more accurate distribution of samples.

Since the new scatter matrixes have been proven to satisfy  $S_t = S_b + S_w$ , any two scatter matrixes can be utilized to construct the "generalized Rayleigh quotient". Generally, it is expressed in the following criterion as

$$\max_{w} \frac{w^{T} S_{b} w}{w^{T} S_{w} w}$$
(10)

Where  $w \in R^{d \times (k-1)}$  is the projection matrix. Then, w can be calculated by

$$\boldsymbol{S}_{b}\boldsymbol{w} = \boldsymbol{\lambda}\boldsymbol{S}_{w}\boldsymbol{w} \tag{11}$$

The closed-form solution of *w* related to k-1 characteristic vectors of  $S_w^{-1}S_b$ .

#### Kernel semi-supervised LDA

The above proposed semi-supervised LDA is a linear dimensional reduction method. In this part, it is extended to the nonlinear range by taking advantage of the kernel method. Firstly, the samples are mapped to the higher space:  $X \to \Phi(X) \in F$ . By combining Eq. (6), (7) and (10), the new kernel objection function is derived as:

$$\max_{w} \frac{w^{T} \Phi(X) S_{b} \Phi(X)^{T} w}{w^{T} \Phi(X) \widehat{S}_{w} \Phi(X)^{T} w}$$
(12)

According to the relevant theory of the reproducing kernel Hilbert space, any solution w of (12) exists in the subspace expanded by all training samples. But when the labeled samples is insufficient, some unlabeled samples around the classification surface of SVM have small class certainty. To reduce the influence of these unlabeled samples, w is denoted by:

$$\boldsymbol{w} = \sum_{j=1}^{N} \boldsymbol{a}_{j} \boldsymbol{p}_{j}^{s} \Phi(\boldsymbol{X}_{j}) = \Phi(\boldsymbol{X}) diag(\boldsymbol{p}^{s}) \boldsymbol{a}$$
(13)

where  $p^{s} = \sum_{i=1}^{k} P^{i}$  comprehensively measures the reliability of training samples and *a* is a vector.

When the sample  $x_j, j \in \{1, 2..., N\}$  is near the surface of SVM,  $p_j^s$  is relatively small. That is, the impact of  $x_j$  in kernel process can be ignored, which ensures the stability of the kernel semi-supervised LDA method.

Then the new kernel object function based on (12), (13) can be obtained as follows:

$$J = \frac{a^{T} \operatorname{diag}(\boldsymbol{p}^{s})\phi(\boldsymbol{X})^{T} \phi(\boldsymbol{X})\boldsymbol{S}_{b}\phi(\boldsymbol{X})^{T} \phi(\boldsymbol{X})\operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{a}}{a^{T} \operatorname{diag}(\boldsymbol{p}^{s})\phi(\boldsymbol{X})^{T} \phi(\boldsymbol{X})\widehat{\boldsymbol{S}}_{w}\phi(\boldsymbol{X})^{T} \phi(\boldsymbol{X})\operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{a}}$$

$$= \frac{a^{T} \operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{K}\widehat{\boldsymbol{S}}_{b}\boldsymbol{K}\operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{a}}{a^{T} \operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{K}\widehat{\boldsymbol{S}}_{w}\boldsymbol{K}\operatorname{diag}(\boldsymbol{p}^{s})\boldsymbol{a}}$$

$$(14)$$

where  $\mathbf{K} = \phi(\mathbf{X})^T \phi(\mathbf{X})$  represents the kernel matrix. Then  $\mathbf{a}$  can be calculated by (11), and  $\mathbf{w}$  can be obtained according to (13).

#### 2.4 Classification

When reducing the dimension of test data, we can select semi-supervised LDA or kernel semisupervised LDA based on whether the data condition is linear. After the dimension reduction, the test data will be classified. There are several classifiers to be selected, such as SVM, random forest, nearest neighbor classifier (NNC) and so on. We adopts the NNC in this part because the training samples of the same class in the projection subspace are very close, which makes the mean vectors fully represent the characteristic information of every class. The mean vectors  $\hat{u}_i$  after dimension reduction can be expressed as

$$\widehat{\boldsymbol{u}}_{i} = \boldsymbol{w}^{T} \boldsymbol{u}_{i}, i \in \{1, 2\cdots, k\}$$

$$(15)$$

Then the class of test sample is determined by the nearest  $\hat{u}_i$ . Clearly, because of its simplicity and strong feasibility, NNC is exactly suitable for the specialty of data in the projection subspace.

# **3** Experiment

In this section, the performance of the proposed method is investigated on the Moving and Stationary Target Acquisition and Recognition (MSTAR) database. The discussion of CCS is performed initially to demonstrate the feasibility of CCS-related steps. Subsequently, the effectiveness of the proposed method is verified by comparing CCS with other semi-supervised algorithms. As shown in Fig 3, we choose BMP2 (sn-c21), T72 (sn-132) and BTR70 (sn-c21) as the training data in the following experiments. Meanwhile, we select BMP2 (sn-c9566), T72 (sn-s7) and BTR70 (sn-c70) as the testing data. Table 1 lists the number of vehicles in the aforementioned data sets.



**Fig 3. The SAR images of three classes of vehicles.** (a) T72, (b) BMP2, and(c) BTR70 **Table 1. Types and quantities of training data and testing data.** 

	Training data			Testing data		
Туре	T72	BMP2	BTR70	T72	BMP2	BTR70
(model)	sn_132	sn_c21	sn_c71	sn_s7	sn_9566	sn_c70
Quantity	232	232	232	191	191	191

## 3.1 Discussion of CCS

When deriving the class certainty of unlabeled samples, we utilize KLDA to reduce the dimension of training data. To verify the superiority of KLDA, we compare it with KPCA, which is a widely used unsupervised dimension reduction method [16]. The influence of the two methods on CCS performance are comparatively analyzed. As the percentage of the labeled sample changes, the overall accuracy (OA) trend chart of different methods is shown in Fig 4. Obviously, the KLDA-CCS possesses higher classification accuracy than KPCA-CCS. The reason is that KLDA not only absorbs the spectrum information of samples, but also further absorbs the label information, leading to better sample characterization ability than KPCA.





To demonstrate the effectiveness of semi-supervised LDA, we compare it with LDA which just utilizes labeled samples. As shown in Fig 5 (a), since test-BMP is closest to the mean vector of T72 samples, the classification result is mistaken. Different from LDA, semi-supervised LDA can represent the truer feature distribution of samples by absorbing the characteristic information of unlabeled samples. Meanwhile, different classes of samples are more separable and the test sample is closer to the right mean vector. As presented in Fig 5 (b), the test-BMP is obviously closest to the u-BMP and is correctly classified into BMP.



Fig 5. The dimension feature of three classes of labeled vehicles samples in LDA and semisupervised LDA. test-BMP represents a testing sample selected from the BMP vehicles, and u-BMP,u-BTR,u-T72 denote the class mean vector and the direction of arrow represents the class judgment result of the test-BMP.

## 3.2 Comparison with other semi-supervised algorithms

In this section, we compare the performance of our method with that of the label propagation(LP) [17], progressive semi-supervised SVM with diversity(PS3VM-D) [14],constrained KMeans(C-KMeans) [18]and semi-supervised discriminant analysis(SDA) [19]. As the percentage of labeled samples changes, the OA trend chart of different methods can be derived, as shown in Fig 6.



#### Fig 6. Classification performance of CCS and the other four semi-supervised algorithms.

Obviously, CCS outperforms the other four semi-supervised algorithms by at least 8% accuracy when the labelled samples are insufficient. Generally, LP and PS3VM-D assign pseudo labels to unlabeled samples. However, the wrong pseudo labels will cause a bad influence on subsequent classifier training process. In terms of the C-KMeans, it can't make full use the spectrum information by adding constraints, which leads to little performance improvement. As for SDA, it focuses on maintaining the neighborhood relationship between samples, but has a high requirement of data distribution. Compared with the aforementioned four methods, CCS not only utilizes the class information of labeled samples, but also reliably absorbs the characteristic information of unlabeled samples through integrating the class certainty of samples into LDA, which makes the classification performance more stable and accurate.

# 4 Conclusion

To effectively solve the problem of RS images classification when labeled samples are insufficient, this paper proposes a novel semi-supervised classification method (CCS). There are three major findings:

(a) Based on the dimensional reduction of training samples and multi-class SVM based learning, the class certainty information is obtained and assigned to unlabeled samples for further processing.

(b) For the unlabeled samples, the pre-processed class certainty respectively reassigns the weight for reliable data and unreliable ones by normalizing and threshold processing.

(c) By combining class certainty and kernel method, the semi-supervised LDA is extended to nonlinear dimensional reduction. The proposed LDA can make full use of class information of labeled samples while characterizing reliably unlabeled samples.

From the experiment results, we observe that the CCS significantly improves the classification accuracy of RS images especially when the labeled samples are insufficient.

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